

SPECIFICATION FOR APPROVAL

规格书

NO 编号: CY20200723-01

CUSTOMER 客 户: _____

PRODUCT 产 品: CRYSTAL RESONATOR

P/N 料 号: _____

MODEL NO 型 号: S9.81563MW

PREPARED 编 制: _____ CHECKED 审 核: _____

APPROVED 批 准: _____ D A T E 日 期: 2020-07-23

CUSTOMER 客户确认意见:

CHECKED 审 核:

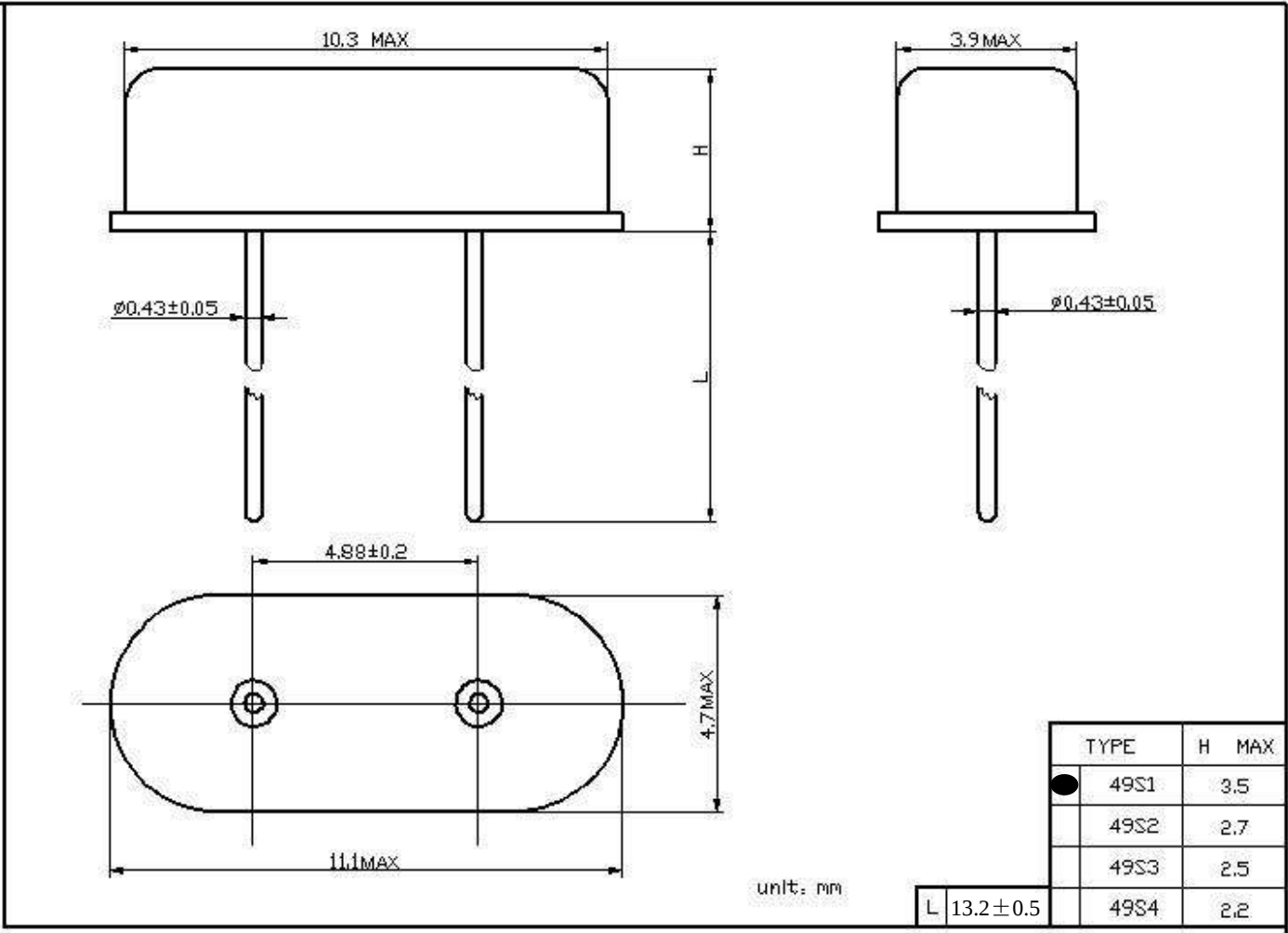
APPROVED 批 准:

D A T E 日 期:

GENERAL SPECIFICATIONS（电气特性）：

1.Holder type: (型号)	S9.81563MW	
2.Normal Frequency: (标称频率)	9.815630MHz	
3.Oscillation Mode: (振动模式)	AT-Fundamental	
4.Load Capacitance(CL): (负载电容)	10 PF	
5.Frequency Tolerance 25±3℃: (频率偏差 25±3℃)	± 15 PPM	
6.Effective Series Resistance: (等效电阻)	≤ 50Ω	
7.DLD2 (不同功率下之最大与最小阻抗差值)	≤ 15Ω	0.01 uW~100 uW 10 steps
8.RLD2 (不同功率下之最大阻抗值)	≤ 50Ω	0.01 uW~100 uW 10 steps
9.FDLD (不同功率下之最大与最小 FR 差值)	≤ 8 PPM	0.01 uW~100 uW 10 steps
10.Shunt Capacitance(C0): (静态电容)	≤ 7 PF	
11. Typical drive level: (激励功率)	100 uW TYP.	
12.Operation Temperature Range: (工作温度范围)	-40℃ to +85℃	
13.Stability Over Temperature Range: (工作温度频率偏差)	±30 PPM at -40℃ to+85℃	
14.Insulation Resistance: (绝缘阻抗)	≥500 MΩ at DC 100V	
15.Aging: (老化率)	±5 PPM/Year	
16.Storage Temperature: (存储温度)	-50℃ to +105℃	
17.Test circuit (测试仪器)	S&A 250B Pi-Network Crystal Measurement System	
Remark (备注) :		

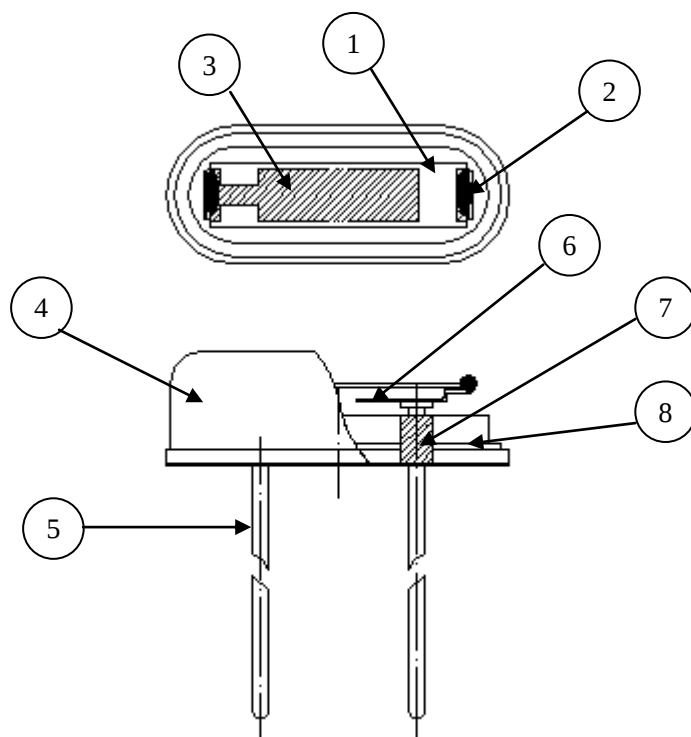
DIMENSIONS SPECIFICATIONS (外形尺寸)



MARK (印字)

S9.81563MW

Report of bills of materials and suppliers (物料清单及供应商)



NO.	Product name 部件名称	MATERIALS 材质	QTY 数量	Supplier 供应商
1	Blank 晶片	SIO2	1	LingHaiRiTai 临海日泰
2	Silver paste 导电胶	3301F	2	THREE BOND 三键
3	Silver 电极	Ag	2	GuangYang 光洋
4	Cover 外壳	Cu	1	TongLingJingSai 铜陵晶赛
5	Lead 引线	Kovar	2	RiZhaoRongDa 日照荣达
6	Pin 簧片	C7701	2	RiZhaoRongDa 日照荣达
7	GLASS 玻璃珠	GLASS	2	RiZhaoRongDa 日照荣达
8	Base 底板	SPCC-SD	1	RiZhaoRongDa 日照荣达

PACKING METHOD(包装样式)

1、Packed 200 pcs in 1 vinyl bag

200pcs—小袋

2、Packed 10 vinyl bag in 1 box, Size of carton:150mm*100mm*100mm

10小袋一盒，纸盒尺寸：150mm*100mm*100mm

3、Packed 10 box in 1 carton

10盒一箱

4、There are 20000 pcs in 1 carton

总计20000pcs 一箱

5、Size of carton:320mm*270mm*230mm

外箱尺寸：320mm*270mm*230mm

6、Label mode

标签样式

A: Part NO.

B: Holder Type

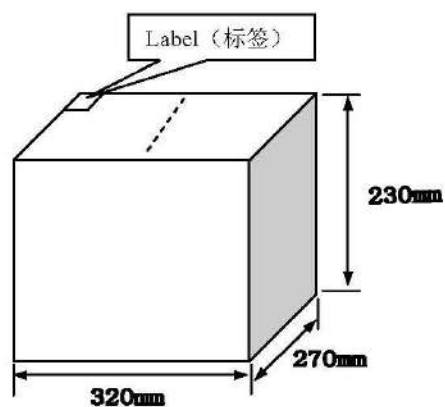
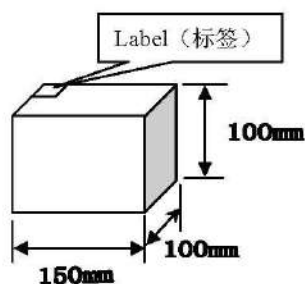
C: Frequency

D: CL

E: $\Delta f_1/f_0$

F: ESR

G: Quantity



RELIABILITY SPECIFICATIONS 可靠性测试标准

NO.	ITEMS 项目	CONDITIONS 条件	SPECIFICATION 规格
1	Lead Bend 端子强度	a) Pulling: According to experiment of IEC 68-2-21 Ua1 experiment, pull 10N.	B
		a) 拉力: 按IEC 68-2-21中试验Ua1进行, 拉力10N。	
		b) Bending: According to experiment of IEC 68-2-21 method Ub. Add the burthen of 5N to lead, and 2.5±0.5mm refer to the base for 3 times.	
		b) 弯曲强度: 按IEC 68-2-21中试验Ub进行, 负荷应限制在距晶体元件本体2.5±0.5mm处开始弯曲, 所加质量负荷为5N, 弯曲次数为3次。	
2	Solderability 可焊性	According to experiment of IEC 68-2-20 Ta method 1, Solder temperature is 235℃.	C
		按IEC 68-2-20中试验Ta的方法1进行, 焊接温度235℃。	
3	Solder heat resistance 耐焊接热	According to experiment of IEC 68-2-20 method Tb 1A: solder slit method. Solder temperature: 260±5℃, dip time 10±1s.	A
		按IEC 68-2-20试验Tb方法1A: 焊锡槽方法进行。 焊接温度: 260±5℃, 浸入时间: 10±1秒。	
4	Vibration 耐振性	According to experiment of 68-2-6 method Fc, The entire frequency range, from 10Hz to 55Hz and return to 10Hz, and shall be transferred in 1 min. Amplitude (total excursion): 1.5mm Duration=2 hours for each of the main axes (x,y,z).	A
		按IEC 68-2-6试验Fc进行, 振动频率在1分钟内从10~55Hz, 再回到10Hz, 振幅1.5mm, X、Y、Z三个方向各2小时。	
5	Shock 耐冲击性	According to experiment of IEC 68-2-27 method Ea, the biggest acceleration : 981m/s ² (100g), work time : 6ms, and 6 surfaces, and 3 directions for each surface, and shall be Shocked 18 times in total.	AB
		按IEC 68-2-27试验Ea进行, 最大加速度: 981m/s ² (100g), 作用时间: 6ms, 6面, 每面三个方向, 共18次。	
6	Cold 耐寒性	According to experiment of IEC 68-2-1 method Aa, The quartz crystal unit should be stored at a temperature -40±3℃ for 2 hours, and then it shall be subjected to standard atmospheric conditions for 1 hour, after which measurement shall be made.	A
		按IEC 68-2-1试验Aa进行, 晶体在温度-40±3℃中放置2小时后, 在常温常湿状态下放置1小时后测试。	
7	Dry Heat 干热	According to experiment of IEC 68-2-2 Ba, quartz crystal unit should be stored at a temperature 85±2℃ for 2 hours. Then it shall be subjected to standard atmospheric conditions for 1 hour, after which measurement shall be made.	A
		按IEC 68-2-2试验Ba进行, 晶体在温度85±2℃中放置2小时后, 在常温常湿状态下放置1小时后测试。	
8	High heat and high humidity 稳 态湿热	According to experiment of IEC 68-2-3 method Ta, quartz crystal unit should be stored at a temperature 40±2℃ and at humidity 90~95% for 96 hours. Then it shall be subjected to standard atmospheric conditions for 1 hour.	A
		按IEC 68-2-3试验Ta进行, 晶体在温度40±2℃, 湿度90~95%中放置96小时后, 在常温常湿状态下放置1小时后测试。	
9	Temperature Cycling 温度 变化	According to experiment of IEC 68-2-14 method Na, quartz crystal unit shall be made 5 temperature cycles, and then it shall be subjected to standard atmospheric conditions for 1 hour.	A
		按IEC 68-2-14试验Na进行, 晶体按下表做5个温度循环后, 在常温常湿状态下放置1小时后测试。	
		TEMPERATURE 温度	STORE TIME 放置时间
		1	-40±3℃
		2	Normal Temp(常温)
		3	100±2℃
		4	Normal Temp(常温)

10	Drop 跌落	According to experiment of IEC 68-2-32 method Ed,quartz crystal unit shall be dropped from 75cm height on 3cm hard board for 3 times.	AB
		按IEC 68-2-32试验Ed进行，晶体从75厘米高度自由下落至3厘米硬木板，重复3次。	
11	Reflow 回流焊	Reflow soldering cure see the chart.	A
		回流焊曲线见下图。	
12	Leakage 气密性	Alcohol press method:quartz crystal unit shall be immersed in the can,and pressed by 0.5kg press for 30min;Then put away press ,and dry it.Quartz crystal unit shall be test insulation resistance by 100V volts d.c for 1 min.	D
		酒精加压法：晶体浸入酒精罐中，加压（压力0.5kg，时间30分钟）；撤去压力后，晾干晶体，测量引线与外壳之间绝缘电阻（100V直流电压，时间1分钟）。	
13	Aging 老化	Quartz crystal unit shall be stored at a temperature $85\pm 2^{\circ}\text{C}$ for 720 ± 12 hours(30days),and then it shall be subjected to standard atmospheric conditions for 1 hour.	A
		晶体在温度 $85\pm 2^{\circ}\text{C}$ 中放置720小时（30天） ± 12 小时后，在常温常湿状态下放置1小时后测试。	

Accept Level:

判定标准:

No.	specification 标准
A	Satisfying the electric characteristic; Frequency change is at the range of 5PPM and resistance change is at the range of 5Ω .
	电气性能可满足要求：频率变化量在5ppm以内,电阻变化量在 5Ω 以内。
B	After each test,no visible damage shall be manifested,nor shall the hermetic seal break down
	试验后，无机械损伤
C	Dipping in 3 sec.A new uniform coating of solder shall covera minimum of 95% of the surface being immersed.
	浸锡时间3秒以内，引线挂锡面积95%以上。
D	Insulation resistance of leads shall be more than $500\text{M}\Omega(100\text{V DC})$.
	端子之间的绝缘电阻 $\geq 500\text{M}\Omega(100\text{V DC})$ 。